Role of irradiation and irradiation defects on the oxidation first stages of a 316L austenitic stainless steel

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ABSTRACT

The role of irradiation and irradiation defects on the oxidation first stages of 316L alloy was investigated. A sample with both a proton pre-irradiated and an unirradiated area was exposed to a simulated PWR environment during 24 hours. Irradiation defects and Radiation Induced Segregation at grain boundary and on irradiation defects were characterized and quantified and their effect on the oxidation was evaluated. Irradiation affects the morphology, thickness and chemistry of the oxide layers formed. It enhances the oxidation kinetic and induces the formation of an inner oxide richer in chromium. Defects induced by irradiation act as preferential nucleation sites.

1. Introduction

Since the 316L alloy possess a high corrosion resistance thanks to the formation of a thin oxide film when exposed to aqueous solutions, it is currently used as a constituent for the baffle to former bolts in French Pressurised Water Reactors (PWRs). These bolts are subjected to a heavy neutron irradiation at temperatures ranging from 300°C to 380°C. In such conditions the bolts are simultaneously exposed to a corrosive environment at a high temperature and under mechanical stresses but also to the neutron flux emitted by the reactor core. This can lead to the cracking of a few bolts by a degradation mechanism called Irradiation Assisted Stress Corrosion Cracking (IASCC). IASCC is a major concern for the maintenance of nuclear power plants and a complex phenomenon. Irradiation is providing an enhancement of the susceptibility of the material to Stress Corrosion Cracking (SCC). Since the rupture of the oxide film formed is the first step in the SCC corrosion process, the nature, structure and chemistry of the oxide formed are key parameter to better understand and predict SCC initiation. It is therefore of primary concern to study the influence of irradiation on the oxide formed on top of austenitic stainless steels.

In the literature, the oxide formed on austenitic stainless steel exposed to PWR media is reported to be duplex and of spinel structure (M\textsubscript{2}O\textsubscript{4}) \cite{1–5}. The inner oxide layer is chromium rich, protective and described as a mixed iron/chromium spinel ((Ni,Fe)\textsubscript{2}Cr\textsubscript{2}O\textsubscript{4}) while the outer oxide is found to be crystallites of geometric shapes of magnetite (Fe\textsubscript{3}O\textsubscript{4}). Many authors observed a nickel enrichment below the metal/oxide interface \cite{5–7}. The inner oxide layer is formed by anionic diffusion whereas the outer crystallites grow from a cationic diffusion mechanism coupled with a precipitation mechanism of dissolved cations in the medium, originating from a diffusion process within the inner layer \cite{1,7,8}. Soulas \cite{5} demonstrated that the inner oxide layer share an epitaxial relationship with the substrate after 24 hours oxidation but many authors observed a polycrystalline oxide \cite{6,9,10}.

Irradiation is known to induce changes in the bulk material like the formation of frank loops and cavities but also Radiation Induced Segregation (RIS) on grain boundaries as well as on irradiation defects \cite{11–13}. Proton irradiation was shown to be an effective tool to emulate the PWRs neutron irradiation and faithfully reproduce the loop and cavity population and the RIS \cite{14,15}. Transmission Electron Microscopy (TEM) is the main tool used for the characterization and quantification of irradiation defects. Electron Energy Loss Spectroscopy (EELS) and Energy Dispersive X-ray Spectroscopy (EDXS) are used to study qualitatively and quantitatively the RIS on grain boundary. However, it is difficult, due to the small size and density of irradiation defects, to detect and quantify chemical modifications on them using TEM. These small segregations can be detected using Atom Probe Tomography (APT) but the nature of the objects on which RIS occurs cannot be found out using APT. Using TEM would allow to link the defects to the segregation occurring on them.

Only a few studies focused on the link between irradiation induced defects and the corrosion of austenitic stainless steels in PWR primary water. In addition, no work studied the effect of irradiation on the

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oxidation first stages. In previous works, irradiation was not found to change the oxide structure. Irradiation nonetheless affects the outer and inner oxides. On irradiated materials, the number of crystallites is always reported higher but Gupta and Dumerval et al. observed smaller crystallites [16,17] whereas Fukuya and Deng et al. bigger ones [9,18]. As for the inner oxide the literature agrees that inner oxide layers formed on an irradiated area are richer in chromium but some works attest that the inner oxide is thicker [16,18] while other that it is thinner [17,19]. These different oxidation behaviours probably arise from the different irradiation and oxidation conditions (dose, temperature, oxidation duration, etc.). Nonetheless, these first results have pointed out some effects of irradiation defects on the oxidation of 316 L alloy in PWR media but their role on diffusion, oxidation kinetic and oxidation mechanisms still remains unclear.

The aim of this paper is to study how irradiation can modify the oxides scales formed on oxidised 316 L and overall affect the oxidation process. This is why the oxides morphology, structure and chemistry where investigated with regards to the concentration of irradiation defects at the surface during the oxidation first stages.

2. Material and methods

2.1. Sample preparation

The studied material is a commercial heat of a solution annealed 316 L alloy. Its chemical composition is presented in Table 1. The metal sheet was hot-rolled and then solution annealed between 1050 and 1150 °C. A sample was machined using Electrical Discharge Machining (EDM) with the following dimensions: 10.85 mm x 11.85 mm x 0.7 mm from the metal sheet. It was mechanically polished on both sides to insure a good thermal transfer during irradiation. The side exposed to the PWR medium was polished down to a colloidal silica suspension. This was made using a specific polishing which was implemented to obtain a sample without any induced hardening or dislocations brought by the polishing steps.

2.2. Proton pre-irradiation

Irradiation conditions were chosen to emulate the neutron irradiation occurring in PWR. The proton pre-irradiation was performed at the CEMHTI of Orleans. The diameter of the irradiated zone was of 4 mm, so that the sample had both irradiated and unirradiated regions. This directly enabled comparative studies of the oxides formed on irradiated and unirradiated areas on a sample with the exact same oxidation conditions. An irradiation dose of 1.5 dpa was chosen to be close to the saturation of the dislocation loops and the RIS phenomenon [11–13]. It was realised at 380 ± 7 °C with a dose rate close to 1.06 × 10⁻⁵ dpa/s and using 1.5 MeV protons. A Stopping and Range of Ions in Matter (SRIM) [20] calculation was performed with Kinchin-Pease cascades using a displacement energy of 40 eV [21]. It showed that defects were created to a depth of 15 μm. After the irradiation, the sample was further polished to reach the irradiation plateau of 1 dpa at a depth of about 2 μm. Before oxidation, the sample was polished using an argon ion polishing (Precision Etching and Coating System (PECS) II from Gatan) to remove the native chromium rich oxide and to remove the carbon contamination induced by the EBSD maps.

2.3. Oxidation

The oxidation was made using a specific corrosion loop [5]. The high pressure and high temperature part of the loop is made of Titanium to avoid metallic contamination coming from the circuit. Ion concentration in the water is brought to a minimum by using a 400 liters mixing tank and ions concentrations were controlled before and after the test. The sample was exposed to simulated PWR water at 325 °C and 155 bar for 24 hours in a dedicated cell coupled to the main loop which allows to perform short time oxidations. In this cell, the sample was in contact with the PWR simulated medium only during the oxidation time. The environment was made of 1000 ppm of boron, 2 ppm of Li, 30 cc/kg of dissolved hydrogen and less than 5 ppb of dissolved oxygen. Argon was used to flush out any unwanted oxygen inside the cell and the sample was heated to the test temperature under argon flux and 5% hydrogen to avoid high temperature oxidation before introducing the medium. At the end of the exposure, the medium was flushed out by an argon flux and the cell was sealed with the argon inside for the cooling down of the cell before its opening.

2.4. Characterisations

Sample observation after oxidation and thin foils were prepared using a FEI Dual Beam HELIOS nanolab 600. Image analysis was realised on the Scanning Electron Microscopy (SEM) images using the ImageJ software [6] to evaluate the outer oxide coverage. Observations and chemical analyses were made on similar grain orientations since Soulas and Matthiew et al. previously shown that they affect the oxidation kinetic [5,22].

TEM foils were further thinned and cleaned in a Precision Ion Polishing System (PIPS) II ion polishing system until the desired thickness was reached. Doing so, the artefacts induced during the lamellae extraction and thinning in the FIB were erased [23,24]. Transmission Electron Microscopy (TEM) analyses and characterization were realised using a FEI Tecnai Osiris 200 kV Scanning TEM (STEM) coupled with a Charge-Coupled Device (CCD) camera. TEM analyses were made to investigate the effect of irradiation on the alloy as well as the oxide scales formed.

This TEM is equipped with a Super-X SDD Energy Dispersive X-ray spectroscopy (EDXS) detector as well as QUANTUM Gatan Imaging Filter (GIF) allowing to perform EDXS and Electron Energy Loss Spectroscopy (EELS) and Energy Filtered Transmission Electron Microscopy (EFTEM) imaging. Thanks to the DigitalMicrograph software, joint EDXS/EELS spectra on a same area were acquired. The DualEELS technology was used to record simultaneously two spectra from different energy and perform accurate EELS quantifications. For the EELS quantification, white lines were excluded from the quantification analysis as they strongly depend upon the chemical state of the species and are not well modelled in cross-section calculations. EDXS quantifications performed without oxygen since the O-Kα x-ray line overlaps the Cr-Lα one. For both EELS and EDXS analyses, composition profiles were determined using line analyses averaged with a probe beam diameter below 1 nm. The acquisitions lasted for several hours up to a few days depending on the acquisition. Quantification were realised without oxygen to provide ratios of metallic species and to write the spinel oxides accordingly to AB₂O₄. No uncertainties were calculated in this work. Results can be assimilated to semi-quantitative ones but will be referred in the following to quantitative since enough counts

<table>
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<th>Element</th>
<th>Wt. %</th>
<th>C</th>
<th>Cr</th>
<th>Ni</th>
<th>Mo</th>
<th>Mn</th>
<th>Si</th>
<th>N</th>
<th>S</th>
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<td>0.005</td>
<td>0.028</td>
<td>0.2</td>
<td>0.009</td>
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</table>

Table 1: Chemical composition of the 316L alloy.
were each time obtained to perform the quantifications presented.

Frank loops were imaged thanks to the Rel-Rod Dark Field (DF) technique in two-beam conditions. To do so the sample was oriented close to [011] zone axis with \( g = 1/2 < 131 > \). The loops were quantified on a representative and with a magnification allowing to image small loops. The total loop density was obtained by multiplying by four the measured density of the imaged family as the loop distribution was considered isotropic along \( (111) \) crystallographic plane. The quantification of the size and density of the loops was made by performing a loop threshold using the ImageJ software [25]. Cavities or voids were imaged using the under/over focus technique. They appear surrounded by a dark fringe in under-focus condition while surrounded by a bright fringe in over-focus condition. Cavities size and density were quantified using the ImageJ software [25]. Efforts were made to estimate the uncertainties at best. Therefore, the lamella thickness and the measured defects number were considered to estimate the densities uncertainties. The standard deviation and the uncertainty on the measurement itself were taken into consideration to estimate the sizes uncertainties. Thickness measurements of the local areas where the defects were imaged were performed by acquiring an unfiltered image and a zero-loss image from the same area under identical conditions.

3. Results and discussion

3.1. Characterisation of irradiation defects

The microstructure induced by the proton irradiation in the studied 316L consisted of dislocation loops and cavities. Fig. 1a) shows the diffraction pattern on the 316L matrix. It was obtained by tilting away from [011] zone axis along \( g = 1/2 < 131 > \) in order to be in two-waves condition. Circled in red in the image is a white streak also called Rel-Rod induced by the presence of Frank loops. By selecting this streak with the objective diaphragm, the Frank loops edge-on are imaged as presented in the Dark Field (DF) images of Fig. 1b) and c). The loops have sizes ranging from 3 nm to 92 nm with an average size of 21 ± 14. The total loop density is of \( 2 \pm 1 \times 10^{22} \text{ m}^{-3} \). These values are consistent with other results both on proton and neutron irradiated austenitic stainless steels [13,14,24,26].

Fig. 2a) show the cavity distribution under-focus on the 316L alloy proton irradiated. Their sizes range from 1 nm to 20 nm with an average size of 11 ± 2 nm and a density close to \( 5 \pm 2 \times 10^{22} \text{ m}^{-3} \). Once again, these results are consistent with others both on proton and neutron irradiated austenitic stainless steels [13,14,24,26]. It confirms that proton irradiation is an efficient tool to simulate the neutron microstructure (Frank loops and cavities). When the cavities reach a sufficient size they appear faceted with facets all parallel from one faceted void to the other. These faceted cavities can be described as regular hexagons stretched along one direction. To gain information on the orientation of each facet, the diffraction pattern (Fig. 2b) was compared to the facets of the cavities. Over the six facets, four of them lie in \( (111) \) planes (shown by the red arrows) while two lie in \( (020) \) planes (shown by the blue arrows) as evidenced in Fig. 2a).

3.2. Radiation Induced Segregation on irradiation defects

Radiation Induced Segregation (RIS) around both the cavities and the loops was investigated in TEM. Quantifications were performed on an area 60 ± 10 nm thick. Fig. 3 presents the Cr, Fe, Ni, Si and Mn EDXS mapping of a cavity. Fig. 4 introduces the atomic composition profiles across a cavity and the tip of a Frank loop edge-on. Both the cavity and the Frank loop are segregated. They are nickel and silicon enriched while depleted in chromium, iron and manganese. On both defects the segregation is not homogeneous and the maximum amount of segregation is around \( \Delta \text{Cr} = -3–6 \text{ at.}\% \), \( \Delta \text{Ni} = +8–13 \text{ at.}\% \) and \( \Delta \text{Si} = +3–5 \text{ at.}\% \). In Fig. 4, the iron segregation possesses a M-shaped profile indicating that iron is pushed back from the defects. By superimposing the STEM Bright Field (BF) image and the chemical map, it appears that segregation occurs on the void surfaces (Fig. 3). On the edge-on loop analysed in Fig. 4, the segregation is especially marked at the loop tips due to a geometric effect. Indeed, the contribution of segregation at the loops extremities in the foil depth is higher. Therefore, our TEM analysis revealed the presence of irradiation defects (Frank loops and cavities) in the 316L alloy induced by the proton irradiation. Similar intragranular segregation on irradiation defects was already evidenced by Atom Probe Tomography (APT) [27–29] in agreement with our results. To the author knowledge, solely Edwards et al. [26] and Fukuya et al. [30] reported segregation on voids or dislocations using TEM but did not present any imaging of it. For the first time, TEM analyses of the RIS intragranular segregation permitted to link the segregated area to the defect nature. These should be combined to APT measurements to provide even more accurate chemical compositions. In addition, these results on a proton pre-irradiated 316L alloy are similar to those on a decommissioned baffle-to-former bolt [24]. Our results demonstrate proton irradiation is an efficient tool to emulate the neutron induced microstructure and microchemistry.

3.3. Effect of irradiation on the oxide morphology and thickness

After 24 hours oxidation, SEM images reveal the presence of an outer oxide in the form of small crystallites on both the unirradiated (Fig. 5a) and the irradiated (Fig. 5b) areas of the 316L sample. The outer layer formed on both regions were compared after oxidation. Bigger and more numerous crystallites are present in the irradiated area inducing a higher outer oxide coverage (75 ± 5 % in the irradiated area vs 58 ± 5 % in the unirradiated one). Their sizes range between

![Fig. 1. Frank loops imaged in TEM a) diffraction pattern on [011] zone axis in 2-beam conditions along 1/2 [1-3-1] (red circle: objective aperture used to image the loops, the scale used in the diffraction pattern is representative of the reciprocal space), b) and c) DF images on the rel-rod streak imaging one loop family edge-on.]
10 and 120 nm. Fukuya et al. [9] and Deng et al. [18] observed a higher number and a bigger size of crystallites as the irradiation dose increase in accordance with our results. Differences in the open literature regarding the outer oxide might originate from the different oxidation durations. In our case we investigated a short oxidation time whereas most studies focus on longer oxidation durations and thus cannot anticipate the effect of irradiation on the oxidation nucleation and growth during the oxidation first stages. In addition, after 24 hours oxidation, specific shapes are observed depending upon the crystallographic orientation of the underlying metal grain in both the irradiated and unirradiated regions as seen in Fig. 5a) and b). This is consistent with Soulas’ results [5]. On [100] grain orientation squared based pyramids are observed whereas flat triangles are seen on top of [111] grain orientation (Fig. 5). No differences in the crystallites shapes were noticed between the irradiated and unirradiated area on a same grain orientation.

TEM cross-section imaging of the oxide formed in both the irradiated and unirradiated region highlighted the presence of a duplex oxide (Fig. 6). The duplex character of the oxide is not affected by irradiation as expected from the literature [9,17–19]. The outer crystallites are formed on top of the inner oxide layer. As previously observed on the SEM images, the outer crystallites are bigger on the irradiated area than on the unirradiated one. Nevertheless, the inner oxide layer is thicker on the irradiated area compared to that formed on the unirradiated one (53 ± 6 nm vs 10 ± 2 nm). Fig. 7 shows TEM bright field images over-focus of the oxide layers formed in the a) and b) unirradiated and c) and d) irradiated area. Since the same sample preparation was used, the brighter regions in the inner oxide layer...
formed on the irradiated area are not due to a thickness difference coming from the foil preparation but are thought to be porosities formed during the oxidation process. The inner oxide layer is dense and continuous in the unirradiated area whereas it is porous in the irradiated area. Further STEM High Angle Annular Dark Field (HAADF) images at grain boundaries were realised to look upon the oxide penetration at the grain boundaries as shown in Fig. 8a) and b) in the unirradiated and irradiated regions respectively. These evidence that the intergranular oxide penetration is deeper in the irradiated area (141 ± 2nm) than in the unirradiated area (42 ± 2nm). The presence of cavities induced by the proton irradiation at the metal/oxide interface is evidenced in Figs. 6b) and 9 a). Similarly, Fig. 9b) and c) reveal the presence of Frank loops at the metal/oxide interface. No preferential oxidation around these defects is observed suggesting that they do not affect the oxidation front.

3.4. Effect of irradiation on the oxide structure

Even if in previous works irradiation was not found to modify the oxide structure, this assumption was verified and the oxide scales formed were looked upon using High Resolution TEM (HRTEM). This HRTEM analysis and associated Fast Fourier Transforms (FFTs) are introduced in Figs. 10 and 11 for the unirradiated and irradiation area respectively. In Fig. 10a), a HRTEM image of the metal, inner oxide and outer oxide are introduced. FFTs of the metal, inner oxide and outer oxide are presented in Fig. 10b)-d) which are the red, green and blue framed areas respectively. For the irradiated area, since the oxide is thicker, both oxides and the matrix could not be imaged at the same time on one HRTEM image. The overall oxide is depicted in Fig. 11a) and the HRTEM image introduced in Fig. 11b) focus on the metal/oxide interface. In the green framed area is presented a FFT of the inner oxide layer. The Inverse FFT (IFFT) of the area framed in red in Fig. 11b) is shown in Fig. 11c). In both the unirradiated and irradiated regions, the inner and outer oxides are indexed as spinel phase $\text{AB}_2\text{O}_4$ (space group Fd-3m). This is consistent with previous finding and, as expected from the literature, irradiation do not affect the crystallographic structure of the oxide layers [9,19].

In the FFTs obtained on the inner oxide layer (green frames of Figs. 10c) and 11 b), no rings suggesting the presence of nanocrystals with an “isotropic” crystallographic orientation distribution can be observed. Indeed, isolated spots are present on the FFTs at specific diffraction angles indicating the presence of an oriented oxide. In Fig. 10e) the FFTs of the inner oxide and the metal are superimposed. The spinel inner oxides are indexed in the same zone axis as the substrate (Fig. 10e). This reveals that a cube/cube epitaxial orientation relationship exists and is established between the inner oxide and the underlying metal grain. The presence of such relationship between the inner layer and the substrate was already mentioned by Soulas on an unirradiated 316L [5]. Our results show that irradiation do not modify the epitaxial orientation relationships established between the oxide layers and the substrate. Nevertheless, as it can be seen in Fig. 11c), the inner oxide layer is heavily strained. The inner oxide region circled in
cyan is not well oriented (off-axis) whereas the region of the inner oxide circled in magenta is well oriented and on-axis. Numerous defects (point defects, dislocations, etc) are believed to be present and would distort the lattice. The presence of a defective monocrystal is in disagreement with the finding of several authors who reported the formation of a polycrystalline oxide [6,9,10].

Regarding the outer crystallites, the faceted ones are in the same zone axis as the inner layer (respectively blue and green frames in Fig. 10d) and c). In Fig. 10f), the FFTs of the inner oxide and outer oxide are superimposed. It reveals that the crystallites grew on the inner oxide layer sharing an epitaxial twin-like relationship with a (1-11) twin plane. Since the same crystallites morphologies were observed on both the irradiated and unirradiated areas (Fig. 5), it is likely that crystallites in the irradiated region also grew onto the inner oxide layer sharing the same epitaxial twin-like relationship.

3.5. Effect of irradiation on the chemistry of the oxides

In this work, to assess the effect of irradiation on the oxides chemistry, we firstly used EFTEM imaging to visualise enrichment in a given element. Fig. 12 shows the EFTEM mapping of the oxide on both the irradiated and unirradiated regions for the oxygen, iron, chromium and nickel. On each map, the regions rich in the map element appear light. The oxide formed after the 24 hours oxidation is visible on the oxygen maps in Fig. 12a) and e). The iron and chromium maps (Fig. 12b), c), f) and g) evidence that the outer crystallites are iron-rich.
whereas the inner oxide layer is chromium rich. A slight nickel enrichment is also seen at the metal/oxide interface as evidenced by red arrows in Fig. 12d) and h). No distinct change can be observed in the qualitative chemistry of the oxide scales between the irradiated and unirradiated area. This is consistent with previous finding [5,6,9,17,19].

Further EDXS, EELS analyses allowed to quantify the enrichments seen in EFTEM mapping. Both EELS and EDXS analyses were performed on the oxides formed in the unirradiated and proton pre-irradiated areas. Fig. 13 reveals the composition profile across both the outer and inner oxides a) in the unirradiated and b) the irradiated areas. Fig. 13a) confirm that the outer oxide is magnetite (Fe₃O₄) and that the inner oxide is a mixed iron/chromium spinel oxide. Since the outer/inner oxide interface is not perfectly planar, between 10 and 15nm in Fig. 13a), the chromium content progressively increase while the iron content decrease before reaching stability. In addition, this EELS linescan reveals that a small amount of nickel is included into the inner oxide layer. The inner oxide layer can thus be describe as (FeCrNi)₃O₄.

At the metal/oxide interface (~26 nm), a clear nickel enrichment coupled with a slight chromium depletion is noticed as already observed in the EFTEM map (Fig. 12d). All these observations are in agreement with other TEM analyses of the oxide scales on unirradiated materials [5,6,9,17,19].

The EELS linescan in the irradiated region presented in Fig. 13b) reveals a duplex behaviour of the inner oxide layer and the presence of an outer oxide iron rich and containing a small amount of nickel. At ~122 nm, as on the unirradiated area, a peak of nickel is visible and highlight a thin nickel enrichment at the metal/oxide interface. Closer to 97 nm on Fig. 13b), the chromium/iron ratio is reversed but the nickel content remain constant between the two regions. Toward the medium/outer oxide the oxide layer is chromium rich while toward the metal the inner oxide is iron-rich. Such duplex inner oxide was only seen on the irradiated area. Since the area close to the metal/oxide interface is poorer in chromium it is less protective than the outer part. These two part of the inner oxide will possess different properties with respect to the anionic transport within the oxide. On the irradiated area, the inner...
oxide was mainly a chromium rich oxide and only small areas exhibited this duplex behaviour.

The results from the quantitative analyses on the inner oxide in the unirradiated area and on the one formed in the irradiated area in the chromium rich region are introduced in Table 2. In this table the results are presented both for the EELS and EDXS analyses. As previously mentioned, the quantification presented in Table 2 were obtained without oxygen. The chromium over chromium/nickel/iron ratios were calculated and the inner spinel oxides are described as AB₂O₄ with A divalent metal cations and B trivalent ones. Overall, from EELS and EDXS analyses, the inner oxide can be written accordingly to (NiₓFe₁₋ₓ)(Cr₁₋ₙFeₙ)₂O₄ with 0.6 ≥ x ≥ 0.3 and 0.9 ≥ y ≥ 0.65. Nickel was always better detected in the EDXS analyses. It relates to EELS sensitivity being lower at higher energy losses while Ni K-line is well detected and quantified in EDXS analysis. A higher amount of chromium is detected in the inner oxide layer formed on the irradiated area (Cr/(Cr + Fe + Ni) unirr ≈ 0.50 vs Cr/(Cr + Fe + Ni) irr ≈ 0.56). The formation of oxide richer in chromium onto irradiated materials was already reported by several authors [16,17,19].

Using the crystal field theory, we can predict the spinel type (normal or inverse) of the oxides as the stabilization energy of the different spinels can be calculated [31]. The AB₂O₄ spinel type is defined according to the distribution of the A and B cations in the cell. In a normal spinel, the B cations are on octahedral sites and the A cations on tetrahedral sites, whereas in an inverse spinel the A cations are in octahedral sites and the B cations half in tetrahedral sites and half in octahedral sites. Normal spinels can be written [A²⁺]([B³⁺]₂O₄) and inverse spinels [B³⁺][B³⁺][A²⁺]O₄ where square brackets represent tetrahedral sites and parentheses octahedral sites.

For an isolated atom, the energy level of the five 3d atomic orbitals are degenerated and possess the same energy. However, cations in octahedral or tetrahedral environments will be subjected to an electrostatic field due to the presence of 6 or 4 ligands respectively. It will cause a splitting Δ of the d-orbitals in two sets with different energies. For the octahedral configuration, three orbitals are stabilised and at a lower energy than the other two. The lower orbitals are referred to as t₂g and the higher ones as eₗ. The crystal field splitting energy are referred as to Δ₀ and Δₜ for octahedral and tetrahedral symmetry respectively.

Ni²⁺, Fe²⁺, Fe³⁺ and Cr³⁺ are all transition metals with [Ar] 4s⁰3d⁸, [Ar] 4s⁰3d⁶, [Ar] 4s⁰3d⁵ and [Ar] 4s⁰3d³ electron configuration respectively. For the iron ions, Fe³⁺ is a high spin system with no Crystal Field Stabilization Energy (CFSE) while Fe²⁺ has a higher CFSE (CFSE = -0.4 Δ₀). This explain the inverse spinel configuration of Fe₂O₄ ([Fe³⁺][Fe²⁺]O₄) since the divalent ion has more gain in octahedral geometry than the trivalent ion. Looking upon a FeCr₂O₄ spinel oxide, Cr³⁺ is a high-spin ion with a higher CFSE than the divalent high-spin Fe²⁺ ion (CFSE_{Fe²⁺} = -1.2 Δ₀ > CFSE_{Fe³⁺}). Therefore, Cr³⁺ occupy the octahedral sites resulting in a normal spinel configuration ([Fe³⁺]([Cr³⁺]₂)O₄) as opposed to a NiFe₂O₄ oxide. Indeed, CFSE_{Ni²⁺} = -1.2 Δ₀ and Ni²⁺ will be in the octahedral sites and Fe³⁺ in tetrahedral sites ([Fe³⁺][Ni²⁺]Fe²⁺O₄). In our case, for a mixed iron/nickel/chromium spinel, Ni²⁺ and Cr³⁺ cations, having higher CFSE than

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<th>Analysed area</th>
<th>Method</th>
<th>Cr (at. %)</th>
<th>Fe (at. %)</th>
<th>Ni (at. %)</th>
<th>Cr/(Cr + Fe + Ni)</th>
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Table 3
EDXS and EELS quantitative analyses of the inner oxides formed on the unirradiated and irradiated areas on a same grain orientation and associated description of the oxides using the crystal field theory.

<table>
<thead>
<tr>
<th>Analysed area</th>
<th>Method</th>
<th>AB₂O₄</th>
</tr>
</thead>
<tbody>
<tr>
<td>Unirradiated</td>
<td>EELS</td>
<td>(Ni₀.₄Fe₀.₆Cr₁.₅Fe₀.₅)O₄</td>
</tr>
<tr>
<td></td>
<td>EDXS</td>
<td>(Fe²⁺Fe²⁺)[Ni₂⁺Cr²⁺Fe²⁺]O₄</td>
</tr>
<tr>
<td>Irradiated</td>
<td>EELS</td>
<td>(Ni₀.₄Fe₀.₆Cr₁.₅Fe₀.₅)O₄</td>
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</table>
Fe$^{2+}$ and Fe$^{3+}$ ions, they will occupy in priority octahedral sites while the iron cations can occupy both tetrahedral and octahedral sites. Table 3 present the description of the spinel inner oxides in the unirradiated and irradiated areas using the results from the EELS and EDXS analyses and the crystal field theory. This analysis could not be substantiated by experimental results on the metal valence state but still provides a valuable chemical description of the oxides. Nonetheless, one should remember that metal valence state will in addition be affected by strain and irradiation.

To better understand where from such differences in the oxide composition might arise, chemical mapping was performed at the metal/oxide interface to investigate the role of irradiation defects. Fig. 14 shows the TEM EDXS analysis made at the metal/oxide interface of O, Cr, Fe, Mn, Ni, Si, Mo. This specific region was chosen to obtain chemical maps of irradiation defects at the metal/oxide interface since a Frank loop is lying edge-on at the oxidation front as shown in the DF image of the loop. This figure highlights that irradiation defects remain segregated near the oxidation front. The Frank loop is still enriched in nickel and silicon and depleted in chromium and iron. However, silicon appears to be depleted from the Frank loop tip located at the oxide front. Silicon probably left the loop tip and is diluted into the surrounding substrate or into the medium as none can be found in the inner oxide layer. No oxygen penetration can be observed toward the loop indicating that no preferential oxidation of the irradiation defects seems to occur at the oxide front. Apart from the silicon, segregation around irradiation defects is not destabilised by the oxidation front and the oxidation process.

EDXS mapping of the grain boundary oxidation in the irradiated area is introduced in Fig. 15 with the O, Cr, Fe, Ni, S, Mn, P, Si and Mo maps. As expected the grain boundary is segregated due to RIS. It is chromium, iron, manganese and molybdenum depleted and nickel, phosphorus and silicon enriched (Fig. 15). By investigating the tip of the intergranular oxidation/RIS, it appears that the silicon and phosphorus contents progressively decrease going from the intergranular RIS toward the oxidation front over 10 nm whereas the Ni tends to accumulate at the tip of the oxide penetration without being included into the oxide. The nickel content reaches \( \sim 50 \) at. % in the oxide penetration tip near region. These observations suggest that silicon and phosphorus are preferentially dissolved into the medium. This behaviour is alike to the one observed for the loop lying at the metal/oxide interface as silicon was also found to be sucked probably into the medium (Fig. 14).

The sulphur map of Fig. 15 evidences a sulphur enrichment at the metal/oxide interface. To confirm its presence, in Fig. 16, two EDXS spectra were extracted, one from the matrix and the other on the believed S-enriched area. As the Kα line of sulphur is really close to the molybdenum Lα line, the spectra were normalised on the Mo-Kα line and attention was paid on the relative intensity of the overall S-Kα and Mo-Kα lines. Since there is a clear increase of intensity of the S-Kα line compared to the Mo-Lα line, it indicates that sulphur is indeed genuinely detected and present at the metal/oxide interface. Tice et al. [32] and West et al. [33] also evidenced sulphur at the metal/oxide. Even if the lamella was extracted away from any visible inclusion, it is believed that such sulphur comes from the dissolution of a nearby MnS inclusion commonly observed in commercial 316 L.

4. Discussion

The experimental results presented above allowed to study the effects of irradiation and especially the effect of irradiation defects such as Frank loops and cavities and those of RIS on the oxides morphology, structure and chemistry.

4.1. Effect of irradiation on the surface oxide structure

Irradiation do not modify the duplex character of the oxide nor the
Fe3O4. This hints towards the existence of a crystallographic orientation (Fig. 5) and are made of magnetite crystallites possessing favoured crystallite morphologies contingent on the oxides spinel structure (Figs. 10 and 11). In both regions, the outer EDXS spectra are zoomed in on the S-Kα/Mo-Lα and Mo-Kα respectively. Fig. 16. EDXS spectra extracted from the areas framed in red in the previous quantitative mapping of the grain boundary oxidation, red and blue framed areas in the EDXS spectra are zoomed in on the S-Kα/Mo-Lα and Mo-Kα respectively.

oxides spinel structure (Figs. 10 and 11). In both regions, the outer crystallites possess favoured crystallites morphologies contingent on the underlying metal grain orientation (Fig. 5) and are made of magnetite (Fe₃O₄). This hints towards the existence of a crystallographic orientation relationship between the substrate and the oxide scales. It also suggests that irradiation does not affect the establishment of the epitaxial relationship. The HRTEM analysis revealed that the chromium rich inner oxide layers are heavily strained oxides sharing a cube/cube epitaxial orientation relationship with the underlying metal grain. Therefore, the presence of irradiation defects near the metal/oxide interface as seen in Fig. 9 do not disturb the establishment of the epitaxial relationship nor the oxide epitaxial growth.

4.2. Effect of irradiation on the surface oxide morphology

The initial microstructure of the irradiated 316L was found to play a key role in the germination and growth of the outer oxide since changes in size and density of crystallites were observed (Fig. 5). Irradiation defects enhance the outer oxide nucleation and act as preferential nucleation sites for the crystallite nucleation during the oxidation first steps inducing the observed higher number of crystallites. Since the outer oxide layer is formed by cationic diffusion within the inner oxide layer and by a dissolution/reprecipitation process [1,8], the bigger size of outer crystallites in the irradiated area reveals that diffusion of cation through the inner oxide layer is faster.

In this work we also observed that the oxide formed on top of the irradiated area is thicker and porous as seen in Fig. 7. It is likely that the porosities arise from imbalanced flux of cationic and anionic species due to irradiation. These porosities provide interconnections between the media and the inner oxide layer/substrate. They act as preferential diffusion paths and are responsible for the faster diffusion of oxygen and metallic cation and therefore the enhanced growth of the outer and inner oxide layers in the irradiated area. This porous oxide is less protective than the one formed on the unirradiated area. The observation of thicker oxides on irradiated material as evidenced in Fig. 6 reveals that irradiation promotes the oxidation kinetic. The oxidation kinetic is up to 5 time faster on the irradiated area after 24 hours oxidation. Among the authors having studied the effect of irradiation for longer oxidation duration, Gupta [34] and Deng [18] also highlighted that irradiation enhances the oxidation kinetic. Both of them reported oxidation kinetics between almost 2 and 4 time faster on the irradiated samples for oxidation during 360 and 500 hours respectively which is coherent with our results. Nonetheless, as the oxidation duration increases and once the oxide is established the oxidation kinetic is believed to slow down. This would explain the slightly lower oxidation kinetic obtain at longer oxidation time. Since inner oxides are thicker on irradiated areas, it indicates that oxygen diffusion through the inner oxide layer is faster on irradiated regions. This enhanced diffusion should result from the high concentration of defects (point defects, dislocations, porosities, etc.) in the oxide scale [8]. However this is contrary to the findings of Perrin et al. who used tracer experiments and observed that oxygen diffusion was slower in the inner oxide layer [19]. This might results from the sample preparation. Indeed, samples in which cold-work is induced by the polishing have slower oxidation kinetics as revealed by Warzee et al. and Ziemniak et al. [35,36]. However, when irradiated this cold-work will disappear since, as shown by Pokor et al. [37], the initial network of dislocations tends to disappear under irradiation. Therefore, for a sample in which the polishing brought cold-work, the irradiated area will be cold-work free and oxygen diffusion will be slower resulting in thinner oxides. This would explain the slower oxygen diffusion in the irradiated area observed by Perrin et al. [19]. Nevertheless, this assumption has to be confirmed with more observations and tracers experiments. In addition, sample polishing have to be controlled and validation of the results obtained in this work using mechanically polished proton (or neutron) irradiated samples is needed to see if the induced cold-work overcome the influence of irradiation.

4.3. Effect of irradiation on the surface oxide chemistry

Irradiation defects such as Frank loops and cavities are present at the metal/oxide interface and are not preferentially oxidised as previously seen in Figs. 9 and 14. Nonetheless, they are thought to promote the metallic cation diffusion toward the metal/oxide interface. This results in the formation of the observed inner oxides richer in chromium (Fig. 13). Such behaviour was already reported by several authors [16,17,19]. The literature attest that oxygen diffusion through the inner layer is slower for Cr-rich oxides [7]. Nonetheless, the presence of porosities in the inner oxide layer acting as diffusion short-cuts is the primarily process responsible for the enhanced growth of the inner
The grain boundaries act as diffusion short-cuts and preferentially oxidised. While intergranular corrosion occurs at the grain boundary in both the unirradiated and irradiated region, the deeper oxide penetration in the irradiated area indicates a promoted intergranular corrosion by irradiation. RIS is likely to be responsible for this preferential oxidation. The low chromium content at grain boundaries induced by RIS (Fig. 15) would increase the grain boundary sensitivity, resulting in higher corrosion susceptibility. Terachi et al. (27) previously reported that the oxidation kinetic is linked to the alloy chromium content. The less chromium in the alloy, the more oxidation is promoted. Even if surface and grain boundary oxidations differ, it is likely that a preferential oxidation would occur at grain boundaries depleted in chromium by the RIS. Nevertheless, this is dependent on the nature of the grain boundary. Grain boundary type and nature are related to the RIS occurring and therefore so is their oxidation behaviour (38,39).

The segregation induced by irradiation was found affected by the oxidation front (Fig. 15). Silicon and phosphorus contents gradually decreased toward the oxide penetration. This suggests that both are sucked from the grain boundary and potentially dissolved into the medium. Such behaviour was already observed on the loop lying at the metal/oxide interface. Nickel, is however preferentially segregated at the oxide tip and accumulate ahead of the oxide front. It is rejected from the oxide toward the metal during its formation and growth. Indeed, iron and chromium possess a higher affinity to oxygen than nickel thus the rate of incorporation of the latter in the oxide is the smallest.

In a nutshell, random grain boundaries in irradiated area will be sensitised by RIS and the chemical composition changes at grain boundaries induced by RIS affect the oxidation and overall SCC resistance. Since grain boundary nature can play a role on the oxide penetration morphology, depth etc., several grain boundaries of different natures should further be investigated.

### 4.5. Synthesis: oxidation mechanism of unirradiated and irradiated 316L exposed to PWR environment during short time

By combining the morphological, structural and structural results, Fig. 17 explains the effect of irradiation on the stainless steel oxidation. Fig. 17a) depicts the oxidation occurring in the unirradiated area. In this region, a duplex oxide is formed and composed of facetted outer crystallites and an inner oxide in epitaxy with the substrate. This inner oxide is formed by an anionic diffusion mechanism and grows toward the metal whereas the outer oxide layer is formed by cationic diffusion within the inner oxide layer and by a dissolution/reprecipitation process [1,8,19]. The inner oxide layer is a mixed iron/chromium/nickel spinel oxide which contains defects and is strained. The outer crystallites are made of maghemite. At the metal oxide/interface a thin nickel enrichment is present and arise from the nickel rejection from the inner oxide. When irradiation defects are presents as shown in Fig. 17b), the metallic ions diffusion is enhanced by their presence and the inner oxide layer is richer in chromium. In the oxidation first stages these defects act as preferential nucleation sites for the outer crystallites inducing a higher number of crystallites. These will grow faster as will the inner oxide layer due to the presence of porosities in the inner oxide enhancing cation and anion diffusions through the inner layer. Therefore, on irradiated materials, the inner oxide layer will be thicker and porous. As for oxidation at grain boundaries (Fig. 17c), the RIS occurring in irradiated materials promotes the oxidation at grain boundaries and induces deeper oxide penetration. RIS was also found affected by the oxidation front and below the oxide penetration the silicon and phosphorus content gradually increase before reaching their RIS content while nickel accumulates in this region due to its rejection from the oxide.

### 5. Conclusion

A solution annealed 316L sample was irradiated using 1.5MeV protons at 380 °C to 1.5 dpa. This study presents the comparison of the oxide formed both in the irradiated and unirradiated region of the sample oxidised in nominal PWR environment.

The following conclusions can be drawn:

- Proton irradiation is an efficient tool to simulate the neutron induced microstructure.
- Irradiation does not affect the duplex character of the oxide nor modify the spinel structure of the oxide and the cube/cube epitaxial orientation relationship established between the oxide scales and the substrate.

Fig. 17. Schematic of the oxidation mechanism of unirradiated and irradiated 316 L austenitic stainless steel exposed to PWR medium during short time oxidations.
M. Irradiation defects act as preferential nucleation sites for the crystallite nucleation inducing the formation of more numerous crystallites on irradiated material.

II. Irradiation enhances the oxidation kinetic and thicker inner oxides as well as bigger crystallites are formed due to the porosity of the inner oxide.

III. Inner oxides are richer in chromium on irradiated materials as irradiation defects enhanced diffusion.

RIS promote grain boundary oxidation and affect the oxidation front by inducing a depleted Si/P area.

References


